

#### N-Channel Enhancement Mode MOSFET

#### **Feature**

- 150V/120A
   R<sub>DS(ON)</sub>=12mΩ(typ.) @ Vss = 10V
- 100% Avalanche Tested
- Reliable and Rugged
- Lead-Free and Green Devices Available (RoHS Compliant)

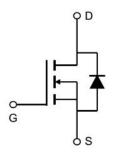
### **Applications**

- Power Switching application
- Uninterruptible Power Supply

### **Pin Description**



TO-262-3L



N-Channel MOSFET

# Ordering and Marking Information



Package Code

I :TO-262-3L

Date Code XYMXXXXXX

Note: HUAYI lead-free products contain molding compounds/die attach materials and 100% matte tin plateTermi-Nation finish; which are fully compliant with RoHS. HUAYI lead-free products meet or exceed the lead-Free requirements of IPC/JEDEC J-STD-020 for MSL classification at lead-free peak reflow temperature. HUAYI defines "Green" to mean lead-free (RoHS compliant) and halogen free (Br or Cl does not exceed 900ppm by weight in homogeneous material and total of Br and Cl does not exceed 1500ppm by weight).

HUAYI reserves the right to make changes, corrections, enhancements, modifications, and improvements to this pr-oduct and/or to this document at any time without notice.



### **Absolute Maximum Ratings**

Symbol	Parameter	Rating	Unit	
Common Rat	tings (Tc=25°C Unless Otherwise Noted)		•	
VDSS	Drain-Source Voltage		150	V
Vgss	Gate-Source Voltage		±25	V
TJ	Maximum Junction Temperature		175	°C
Tstg	Storage Temperature Range		-55 to 175	°C
ls	Source Current-Continuous(Body Diode) Tc=25°C		120	Α
Mounted on	Large Heat Sink		•	
<b>I</b> DМ	Pulsed Drain Current *	Tc=25°C	320	А
	Continuous Danie Coment	Tc=25°C	120	А
lσ	Continuous Drain Current	Tc=100°C	84	А
<b>D</b>	P <sub>D</sub> Maximum Power Dissipation Tc=25°C Tc=100°C		300	W
PD			150	W
R₀JC	Thermal Resistance, Junction-to-Case		0.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient **		62.5	°C/W
Eas	Single Pulsed-Avalanche Energy ***	L=0.3mH	706	mJ

Note: \* Repetitive rating; pulse width limited by max. junction temperature.

\*\* Surface mounted on FR-4 board.

\*\*\* Limited by TJmax , starting TJ=25 $^{\circ}$ C, L = 0.3mH, VDS=100V, VGS =10V.

### Electrical Characteristics (Tc = 25°C Unless Otherwise Noted)

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Symbol	Parameter	Test Conditions		Тур.	Max	Unit
Static Cha	racteristics					•
BVDSS	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V,I <sub>DS</sub> =250μA	150	-	-	V
	V <sub>DS</sub> =150V,V <sub>GS</sub> =0V	-	-	1.0	μA	
loss	IDSS Drain-to-Source Leakage Current	TJ=125°C	-	-	50	μA
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>DS</sub> =250µA	3.0	4.0	5.0	V
Igss	Gate-Source Leakage Current	V <sub>GS</sub> =±20V,V <sub>DS</sub> =0V	-	-	±100	nA
RDS(ON)*	Drain-Source On-State Resistance	V <sub>GS</sub> =10V,I <sub>DS</sub> =40A	-	12	15	mΩ
Diode Cha	racteristics			•	•	
V <sub>SD</sub> *	Diode Forward Voltage	IsD=50A,Vgs=0V	-	0.85	1.3	V
<b>t</b> rr	Reverse Recovery Time	Isp=50A,dIsp/dt=100A/µs	-	81.1	_	ns
Qrr	Reverse Recovery Charge	TISD-SUA, UISD/UI=TUUA/µS	-	322.2	-	nC



# Electrical Characteristics (Cont.) (Tc =25°C Unless Otherwise Noted)

Cumbal	Parameter	Toot Conditions		HY3215		
Symbol		Test Conditions	Min	Тур.	Max	Unit
Dynamic	Characteristics					
Rg	Gate Resistance	V <sub>GS</sub> =0V,V <sub>DS</sub> =0V,F=1 MHz	-	3.0	-	Ω
Ciss	Input Capacitance	V <sub>GS</sub> =0V,	-	6174	-	
Coss	Output Capacitance	V <sub>DS</sub> =25V,	-	549	-	pF
Crss	Reverse Transfer Capacitance	Frequency=1.0MHz	-	298	-	
td(ON)	Turn-on Delay Time		-	39.6	-	
Tr	Turn-on Rise Time	$V_{DD}$ =75 $V$ , $R_{G}$ =3.9 $\Omega$ ,	-	112.8	-	
td(OFF)	Turn-off Delay Time	IDS=50A,VGS=10V	-	81.5	-	ns
Tf	Turn-off Fall Time		-	89.5	-	
Gate Charge Characteristics						
Qg	Total Gate Charge	\/ -75\/ \/ -40\/	-	125.7	-	
Qgs	Gate-Source Charge	$V_{DS}$ =75V, $V_{GS}$ =10V, $I_{D}$ =50A	-	43	-	nC
Qgd	Gate-Drain Charge	ID-OOM	-	46	-	

Note: \*Pulse test, pulse width  $\leq 300$ us, duty cycle  $\leq 2\%$ 



### **Typical Operating Characteristics**

**Figure 1: Power Dissipation** 

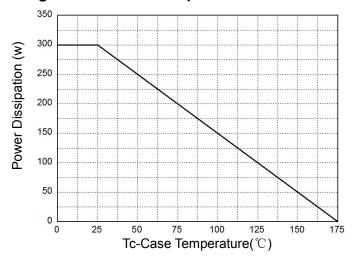


Figure 2: Drain Current

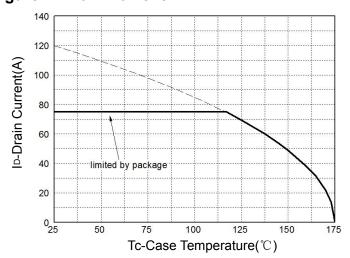
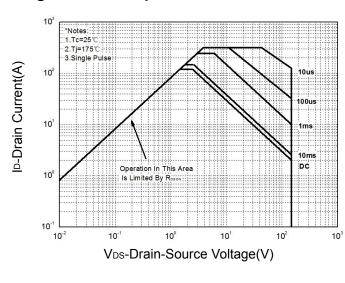
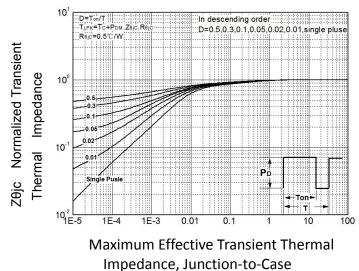


Figure 3: Safe Operation Area



**Figure 4: Thermal Transient Impedance** 



**Figure 5: Output Characteristics** 

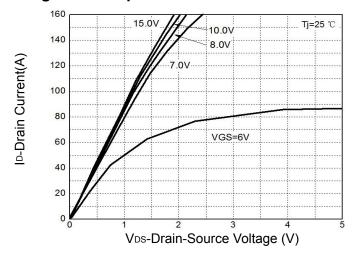
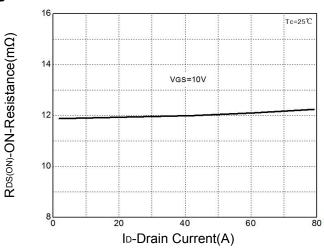


Figure 6: Drain-Source On Resistance





### **Typical Operating Characteristics(Cont.)**

Figure 7: On-Resistance vs. Temperature

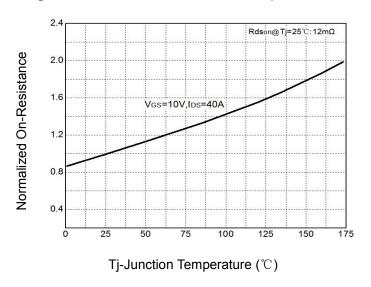
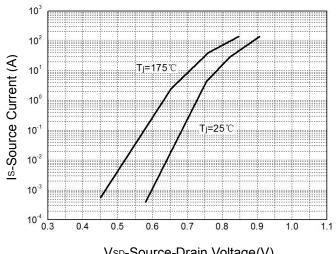
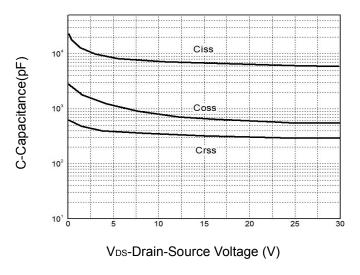


Figure 8: Source-Drain Diode Forward

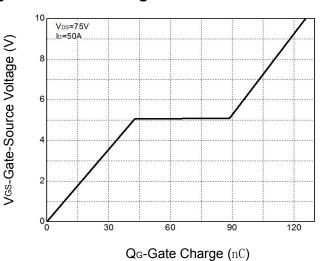


Vsp-Source-Drain Voltage(V)

Figure 9: Capacitance Characteristics

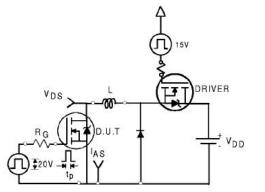


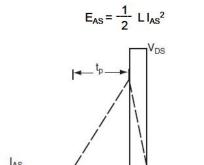
**Figure 10: Gate Charge Characteristics** 



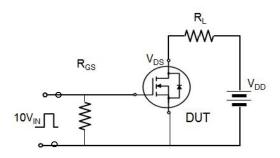


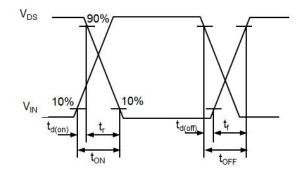
### **Avalanche Test Circuit**



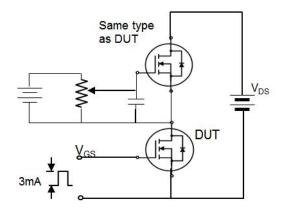


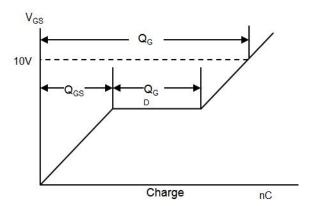
# **Switching Time Test Circuit**





## **Gate Charge Test Circuit**





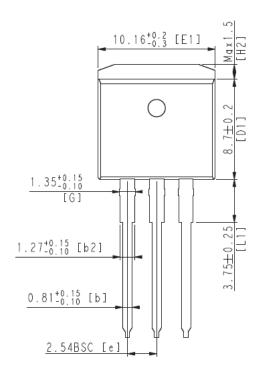


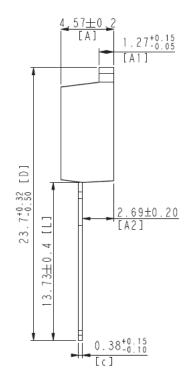
### **Device Per Unit**

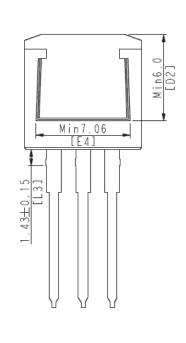
Package Type	Unit	Quantity
TO-262-3L	Tube	50

# Package Information

### TO-262-3L

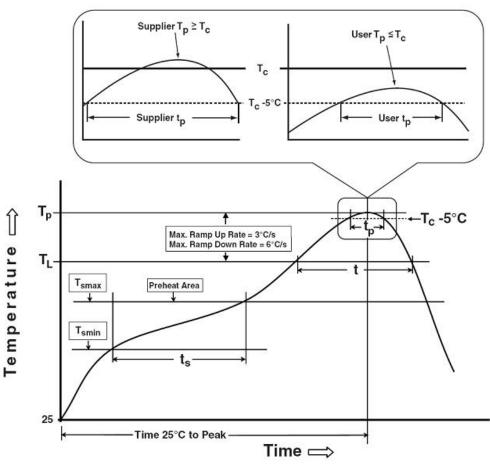








### **Classification Profile**



### **Classification Reflow Profiles**

Sn-Pb Eutectic Assembly	Pb-Free Assembly
100 °C 150 °C 60-120 seconds	150 °C 200 °C 60-120 seconds
3 °C/second max.	3°C/second max.
183 °C	217 °C
60-150 seconds	60-150 seconds
See Classification Temp in table 1	SeeClassification Tempin table 2
20** seconds	30** seconds
6 °C/second max.	6 °C/second max.
6 minutes max.	8 minutes max.
	100 °C 150 °C 60-120 seconds  3 °C/second max.  183 °C 60-150 seconds  See Classification Temp in table 1  20** seconds  6 °C/second max.

<sup>\*</sup>Tolerance for peak profile Temperature (Tp) is defined as a supplier minimum and a user maximum.

<sup>\*\*</sup> Tolerance for time at peak profile temperature (tp) is defined as a supplier minimum and a user maximum.

### HY3215I



Table 1.SnPb Eutectic Process – Classification Temperatures (Tc)

Package	Volume mm³	Volume mm³
Thickness	<350	≥350
<2.5 mm	235 °C	220 °C
≥2.5 mm	220 °C	220 °C

#### Table 2.Pb-free Process – Classification Temperatures (Tc)

Package	Volume mm³	Volume mm³	Volume mm³
Thickness	<350	350-2000	≥2000
<1.6 mm	260 °C	260 °C	260 °C
1.6 mm – 2.5 mm	260 °C	250 °C	245 °C
≥2.5 mm	250 °C	245 °C	245 °C

### **Reliability Test Program**

Test item	Method	Description
SOLDERABILITY	JESD-22, B102	5 Sec, 245°C
HTRB	JESD-22, A108	168/500/1000 Hrs, Bias @ 150°C
HTGB	JESD-22, A108	168 Hrs/500hr/1000hr, V <sub>gs</sub> 100% @ 150°C
PCT	JESD-22, A102	96 Hrs, 100%RH, 2atm, 121°C
TCT	JESD-22, A104	500 Cycles, -55°C~150°C

#### **Customer Service**

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